



ALPHA & OMEGA
SEMICONDUCTOR

AOTF10N50FD

500V, 10A N-Channel MOSFET with Fast Recovery Diode

General Description

The AOTF10N50FD has been fabricated using an advanced high voltage MOSFET process that is designed to deliver high levels of performance and robustness in popular AC-DC applications. By providing low $R_{DS(on)}$, C_{iss} and C_{rss} along with guaranteed avalanche capability this part can be adopted quickly into new and existing offline power supply designs.

Product Summary

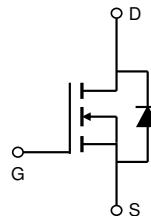
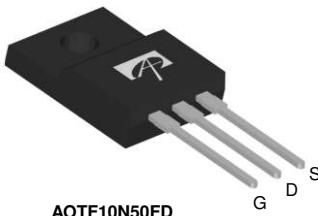
| | |
|---------------------------------|------------|
| V_{DS} | 600V@150°C |
| I_D (at $V_{GS}=10V$) | 10A |
| $R_{DS(ON)}$ (at $V_{GS}=10V$) | < 0.75Ω |

100% UIS Tested
100% R_g Tested



Top View

TO-220F



Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

| Parameter | Symbol | AOTF10N50FD | Units |
|--|-----------------|-------------|-------|
| Drain-Source Voltage | V_{DS} | 500 | V |
| Gate-Source Voltage | V_{GS} | ± 30 | V |
| Continuous Drain Current | I_D | 10* | A |
| $T_C=100^\circ C$ | | 6* | |
| Pulsed Drain Current ^C | I_{DM} | 33 | |
| Avalanche Current ^C | I_{AR} | 3.8 | A |
| Repetitive avalanche energy ^C | E_{AR} | 216 | mJ |
| Single pulsed avalanche energy ^G | E_{AS} | 433 | mJ |
| Peak diode recovery dv/dt | dv/dt | 5 | V/ns |
| $T_C=25^\circ C$ | P_D | 50 | W |
| Power Dissipation ^B Derate above 25°C | | 0.4 | W/°C |
| Junction and Storage Temperature Range | T_J, T_{STG} | -55 to 150 | °C |
| Maximum lead temperature for soldering purpose, 1/8" from case for 5 seconds | T_L | 300 | °C |
| Thermal Characteristics | | | |
| Parameter | Symbol | AOTF10N50FD | Units |
| Maximum Junction-to-Ambient ^{A,D} | $R_{\theta JA}$ | 65 | °C/W |
| Maximum Junction-to-Case | $R_{\theta JC}$ | 2.5 | °C/W |

* Drain current limited by maximum junction temperature.

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

| Symbol | Parameter | Conditions | Min | Typ | Max | Units |
|-----------------------------|---|---|-----|------|-----------|---------------------------|
| STATIC PARAMETERS | | | | | | |
| BV_{DSS} | Drain-Source Breakdown Voltage | $I_D=10\text{mA}, V_{GS}=0\text{V}, T_J=25^\circ\text{C}$ | 500 | | | V |
| | | $I_D=10\text{mA}, V_{GS}=0\text{V}, T_J=150^\circ\text{C}$ | | 600 | | |
| $BV_{DSS}/\Delta T_J$ | Breakdown Voltage Temperature Coefficient | $I_D=10\text{mA}, V_{GS}=0\text{V}$ | | 0.56 | | $\text{V}/^\circ\text{C}$ |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{DS}=500\text{V}, V_{GS}=0\text{V}$ | | 10 | | μA |
| | | $V_{DS}=400\text{V}, T_J=125^\circ\text{C}$ | | 100 | | |
| I_{GSS} | Gate-Body leakage current | $V_{DS}=0\text{V}, V_{GS}=\pm 30\text{V}$ | | | ± 100 | nA |
| $V_{GS(\text{th})}$ | Gate Threshold Voltage | $V_{DS}=5\text{V}, I_D=250\mu\text{A}$ | 2.5 | 3.1 | 4.2 | V |
| $R_{DS(\text{ON})}$ | Static Drain-Source On-Resistance | $V_{GS}=10\text{V}, I_D=5\text{A}$ | | 0.6 | 0.75 | Ω |
| g_{FS} | Forward Transconductance | $V_{DS}=40\text{V}, I_D=5\text{A}$ | | 10 | | S |
| V_{SD} | Diode Forward Voltage | $I_S=10\text{A}, V_{GS}=0\text{V}$ | | 0.93 | 1.6 | V |
| I_S | Maximum Body-Diode Continuous Current | | | 10 | | A |
| I_{SM} | Maximum Body-Diode Pulsed Current | | | 33 | | A |
| DYNAMIC PARAMETERS | | | | | | |
| C_{iss} | Input Capacitance | $V_{GS}=0\text{V}, V_{DS}=25\text{V}, f=1\text{MHz}$ | 820 | 1030 | 1240 | pF |
| C_{oss} | Output Capacitance | | 75 | 112 | 150 | pF |
| C_{rss} | Reverse Transfer Capacitance | | 5 | 10 | 15 | pF |
| R_g | Gate resistance | $V_{GS}=0\text{V}, V_{DS}=0\text{V}, f=1\text{MHz}$ | 1.7 | 3.4 | 5.2 | Ω |
| SWITCHING PARAMETERS | | | | | | |
| Q_g | Total Gate Charge | $V_{GS}=10\text{V}, V_{DS}=400\text{V}, I_D=10\text{A}$ | 20 | 26 | 35 | nC |
| Q_{gs} | Gate Source Charge | | | 4.8 | | nC |
| Q_{gd} | Gate Drain Charge | | | 9.5 | | nC |
| $t_{D(\text{on})}$ | Turn-On Delay Time | $V_{GS}=10\text{V}, V_{DS}=250\text{V}, I_D=10\text{A}, R_G=25\Omega$ | | 24 | | ns |
| t_r | Turn-On Rise Time | | | 65 | | ns |
| $t_{D(\text{off})}$ | Turn-Off Delay Time | | | 69 | | ns |
| t_f | Turn-Off Fall Time | | | 50 | | ns |
| t_{rr} | Body Diode Reverse Recovery Time | $I_F=10\text{A}, dI/dt=100\text{A}/\mu\text{s}, V_{DS}=100\text{V}$ | | 116 | 190 | ns |
| Q_{rr} | Body Diode Reverse Recovery Charge | $I_F=10\text{A}, dI/dt=100\text{A}/\mu\text{s}, V_{DS}=100\text{V}$ | | 0.3 | 0.6 | μC |

A. The value of R_{JJA} is measured with the device in a still air environment with $T_A=25^\circ\text{C}$.

B. The power dissipation P_D is based on $T_{J(\text{MAX})}=150^\circ\text{C}$, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature $T_{J(\text{MAX})}=150^\circ\text{C}$. Ratings are based on low frequency and duty cycles to keep initial $T_J=25^\circ\text{C}$.

D. The R_{JJA} is the sum of the thermal impedance from junction to case R_{JJC} and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using $<300\mu\text{s}$ pulses, duty cycle 0.5% max.

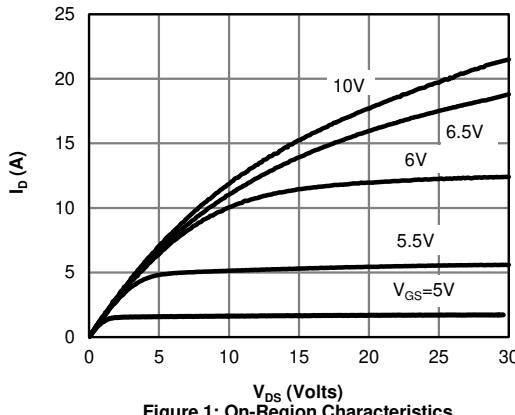
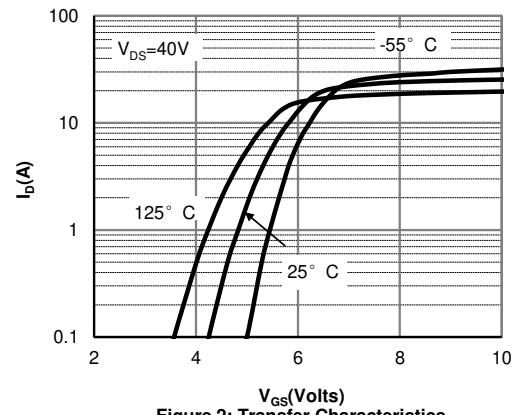
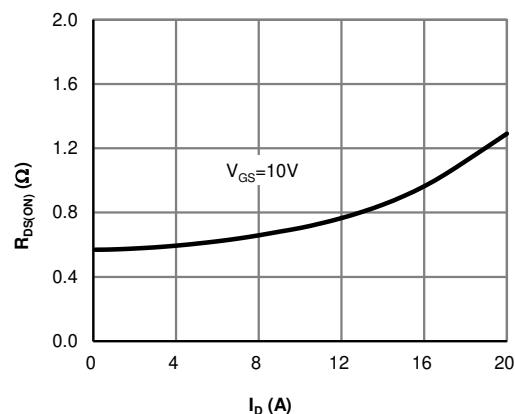
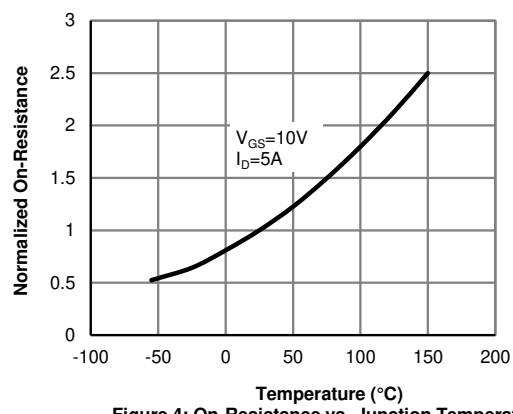
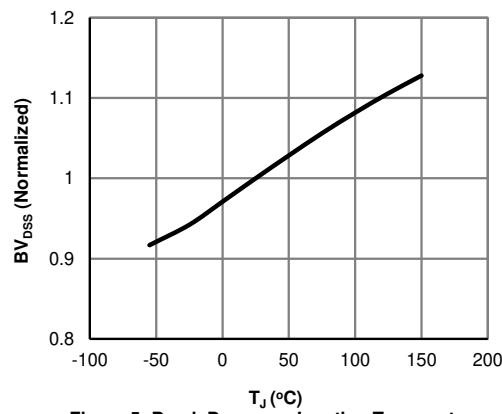
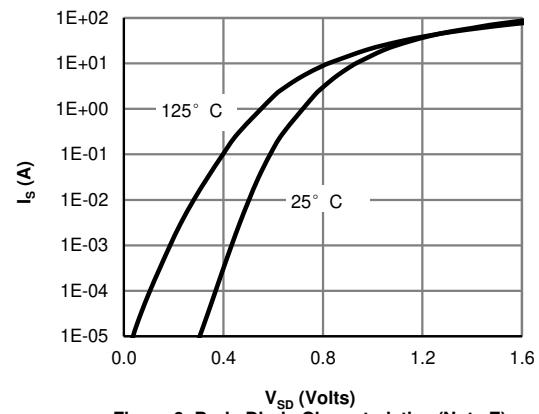
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(\text{MAX})}=150^\circ\text{C}$. The SOA curve provides a single pulse rating.

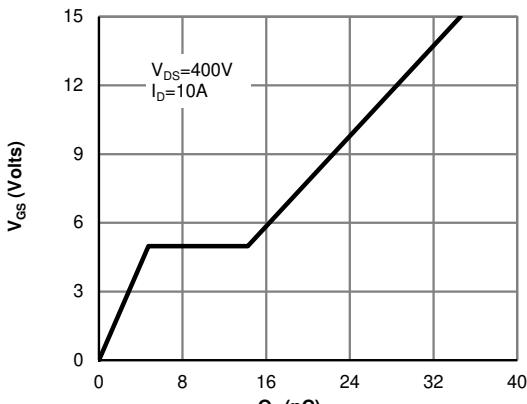
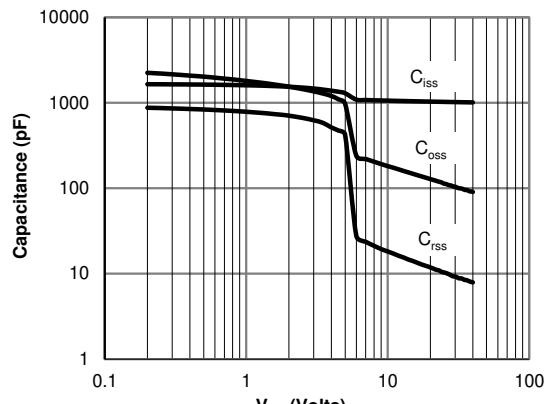
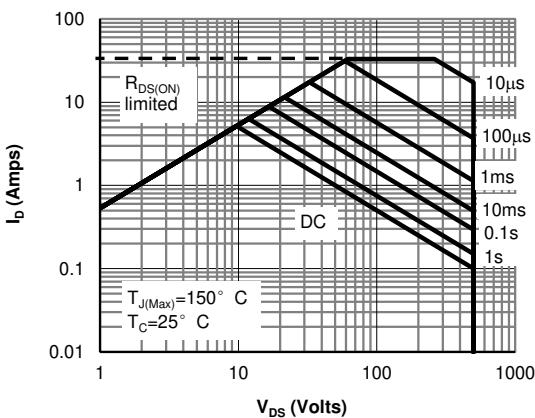
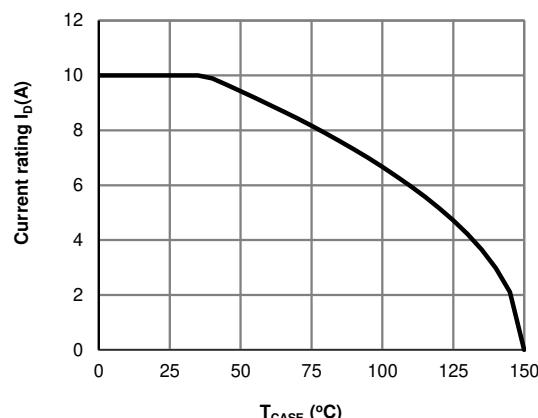
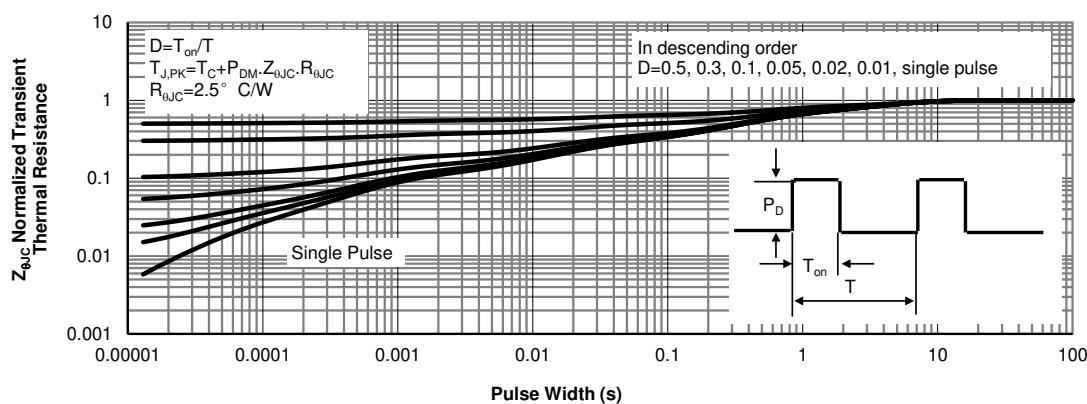
G. $L=60\text{mH}, I_{AS}=3.8\text{A}, V_{DD}=150\text{V}, R_G=25\Omega$, Starting $T_J=25^\circ\text{C}$

APPLICATIONS OR USES AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS ARE NOT AUTHORIZED. AOS DOES NOT ASSUME ANY LIABILITY ARISING OUT OF SUCH APPLICATIONS OR USES OF ITS PRODUCTS. AOS RESERVES THE RIGHT TO MAKE CHANGES TO PRODUCT SPECIFICATIONS WITHOUT NOTICE. IT IS THE RESPONSIBILITY OF THE CUSTOMER TO EVALUATE SUITABILITY OF THE PRODUCT FOR THEIR INTENDED APPLICATION. CUSTOMER SHALL COMPLY WITH APPLICABLE LEGAL REQUIREMENTS, INCLUDING ALL APPLICABLE EXPORT CONTROL RULES, REGULATIONS AND LIMITATIONS.

AOS' products are provided subject to AOS' terms and conditions of sale which are set forth at:

http://www.aosmd.com/terms_and_conditions_of_sale

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

Figure 1: On-Region Characteristics

Figure 2: Transfer Characteristics

Figure 3: On-Resistance vs. Drain Current and Gate Voltage

Figure 4: On-Resistance vs. Junction Temperature

Figure 5: Break Down vs. Junction Temperature

Figure 6: Body-Diode Characteristics (Note E)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

Figure 7: Gate-Charge Characteristics

Figure 8: Capacitance Characteristics

Figure 9: Maximum Forward Biased Safe Operating Area for AOTF10N50FD (Note F)

Figure 10: Current De-rating (Note B)

Figure 11: Normalized Maximum Transient Thermal Impedance for AOTF10N50FD (Note F)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

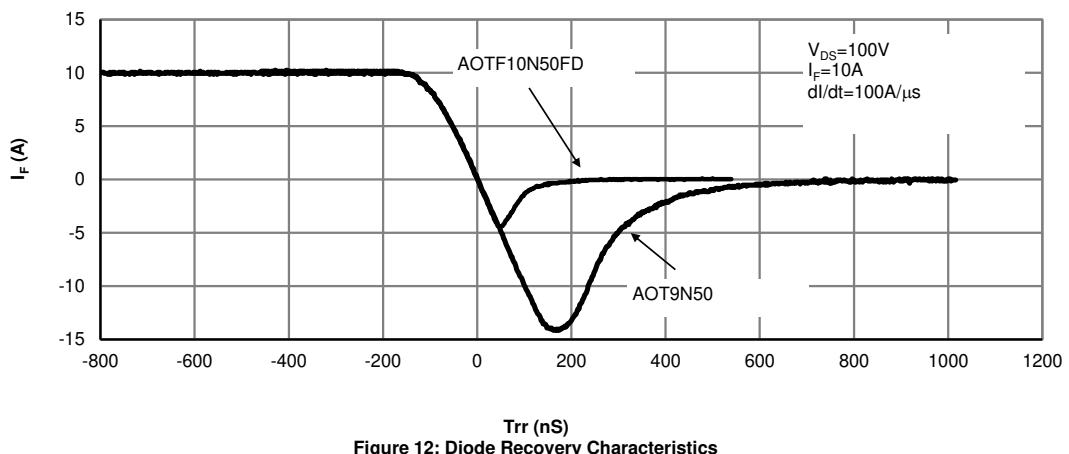
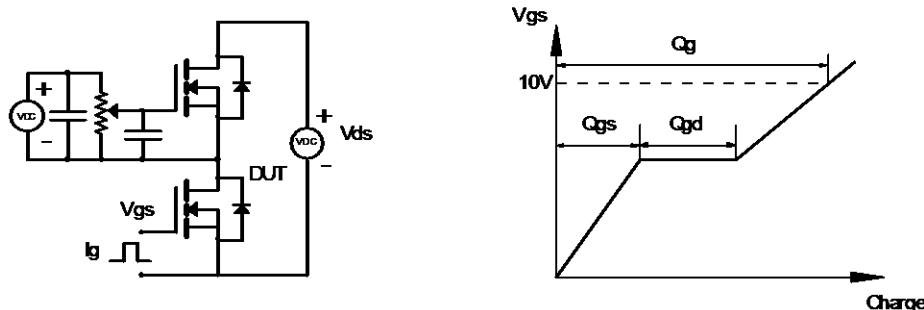
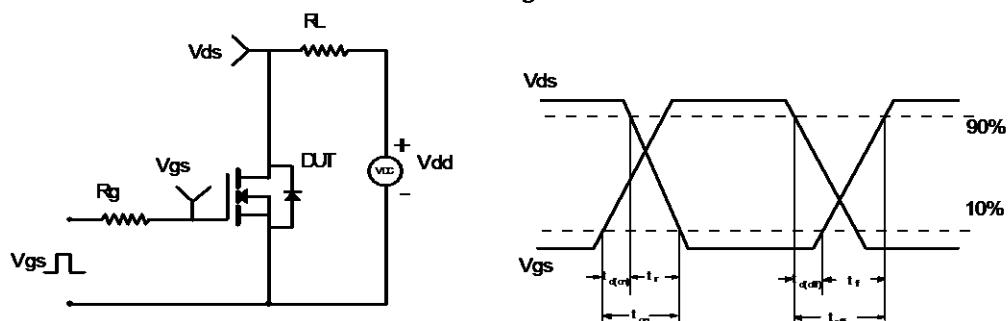
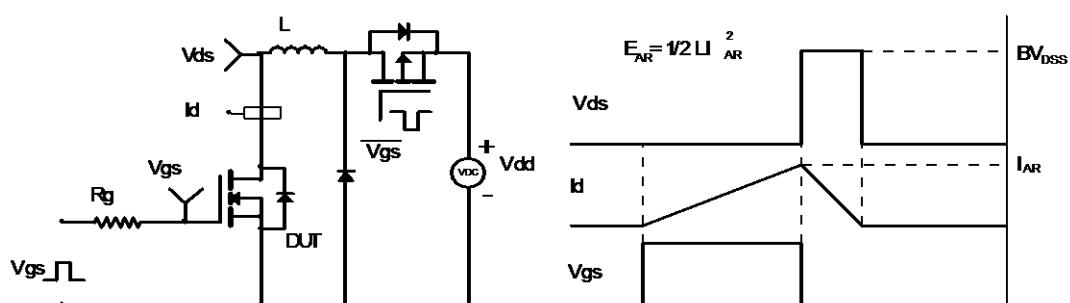


Figure 12: Diode Recovery Characteristics

Gate Charge Test Circuit & Waveform

Resistive Switching Test Circuit & Waveforms

Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

Diode Recovery Test Circuit & Waveforms
